Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/817,273	NISHI, TAKASHI	
Examiner	Art Unit	
Paul D. Kim	3729	

	SEAR	CHED	
Class	Subclass	Date	Examiner
29	606,602.1 846 847	1/9/2006	PK
427	96,97 116		
	123 124		
428	3,42,57 98		
216	2,39,49		
	58,67		
430	313 316	/	
	317	V	

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Reviewed Parent Application 09/914542 (US PAT. 6,725,528)	1/6/2006	PK		